

# **Product Specification**

## **XBLW** AO4409

P-Channel Enhancement Mode MOSFET











#### **Description**

The AO4409 uses advanced trench technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

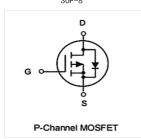
#### Feature:

- $V_{DS} = -30V I_{D} = -15A$
- $\triangleright$  RDS(ON) < 8.7mΩ @ VGS= 10V

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#### **Applications**

- Battery protection Load switch
- Uninterruptible power supply



#### **Ordering Information**

Product Model	Package Type	Marking	Packing	Packing Qty
XBLW AO4409	SOP-8	AO4409	Tape	3000Pcs/Reel

#### **Absolute Maximum Ratings (TC=25℃unless otherwise noted)**

Symbol	Parameter	Rating	Units
Vos	Drain-Source Voltage	-30	V
V <sub>GS</sub>	Gate-Source Voltage	±20	
l₀@T <sub>A</sub> =25°C	Continuous Drain Current, V <sub>GS</sub> @ -10V¹	Orain Current, V <sub>GS</sub> @ -10V <sup>1</sup> -15	
lo@Ta=70°C	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>	us Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup> -11	
Іом	Pulsed Drain Current <sup>2</sup>	Pulsed Drain Current <sup>2</sup> -56	
EAS	Single Pulse Avalanche Energy <sup>3</sup>	Single Pulse Avalanche Energy <sup>3</sup> 151	
las	Avalanche Current	-55	А
Pd@Ta=25°C	Total Power Dissipation⁴	1.5	
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Reja	Thermal Resistance Junction-Ambient ¹(t≤10s)	40	°C/W
	Thermal Resistance Junction-Ambient <sup>1</sup>	75	°C/W
Reuc	Thermal Resistance Junction-Case <sup>1</sup>	24	°C/W



#### **Electrical Characteristics (TJ=25 ℃, unless otherwise noted)**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V <sub>G</sub> S=0V , I <sub>D</sub> =-250uA	-30			V
ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C , ID=-1mA		-0.018		V/°C
		V <sub>GS</sub> =-10V , I <sub>D</sub> =-12A		5.8	8.7	
RDS(ON)	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-10A		8.5	13.5	$\text{m}\Omega$
V <sub>GS(th)</sub>	Gate Threshold Voltage		-1.2		-2.5	V
$\Delta V_{\text{GS(th)}}$	V <sub>GS(th)</sub> Temperature Coefficient	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =-250uA		5.04		mV/°C
	Drain-Source Leakage Current	V <sub>DS</sub> =-24V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C	1			
loss		V <sub>DS</sub> =-24V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			-5	uA
lgss	Gate-Source Leakage Current	V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V			± 100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =-5V , I <sub>D</sub> =-12A		25		S
Qg	Total Gate Charge (-4.5V)	V/DC 45V		30		nC
Qgs	Gate-Source Charge	VDS=-15V VGS=-4.5V		10		
Q <sub>gd</sub>	Gate-Drain Charge	ID=-12A		10.4		
T <sub>d(on)</sub>	Turn-On Delay Time			9.4		- ns
Tr	Rise Time	VDD=-15V VGS=-10V		10.2		
T <sub>d(off)</sub>	Turn-Off Delay Time	RG=3.3		117		
Tf	Fall Time	_ ID=-1A		24		
Ciss	Input Capacitance			3448		
Coss	Output Capacitance	V <sub>DS</sub> =-15V , V <sub>GS</sub> =0V , f=1MHz		508		pF
Crss	Reverse Transfer Capacitance			421		 
ls	Continuous Source Current <sup>1,5</sup>				-14	Α
Іѕм	Pulsed Source Current <sup>2,5</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-56	Α
VsD	Diode Forward Voltage <sup>2</sup>	V <sub>G</sub> s=0V , I <sub>S</sub> =-1A , T <sub>J</sub> =25°C			-1.2	V
trr	Reverse Recovery Time	I <sub>F</sub> =-10A , dI/dt=100A/μs ,		19.4		nS
Qrr	Reverse Recovery Charge	T <sub>J</sub> =25°C		9.1		nC

#### Note:

<sup>1.</sup> The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

<sup>2.</sup>The data tested by pulsed , pulse width  $\leq 300$ us , duty cycle  $\leq 2\%$ 

<sup>3.</sup> The EAS data shows Max. rating . The test condition is  $V_{DD}$ =-25V,  $V_{GS}$ =-10V, L=0.1mH,  $I_{AS}$ =-

<sup>55</sup>A 4.The power dissipation is limited by 150°C junction temperature

<sup>5.</sup> The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.



#### **Typical Characteristics**

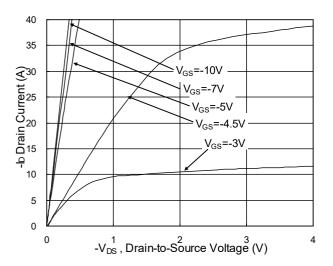


Fig.1 Typical Output Characteristics

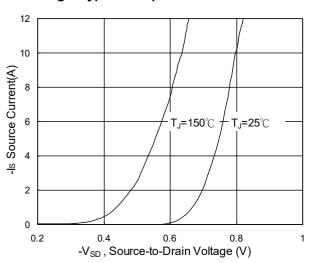


Fig.3 Forward Characteristics Of Reverse

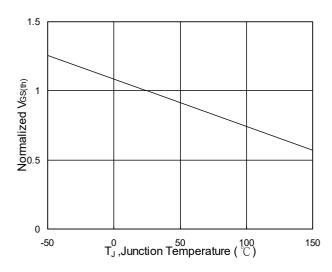


Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$ 

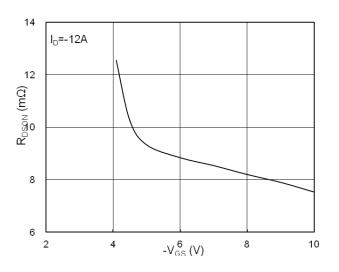


Fig.2 On-Resistance v.s Gate-Source

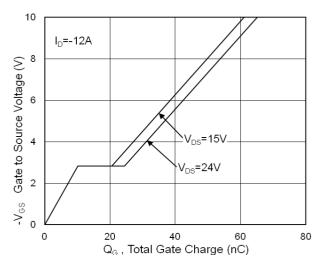


Fig.4 Gate-Charge Characteristics

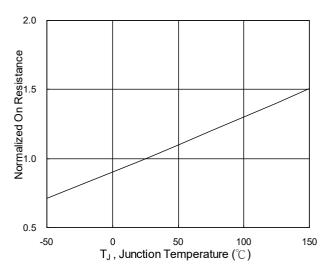
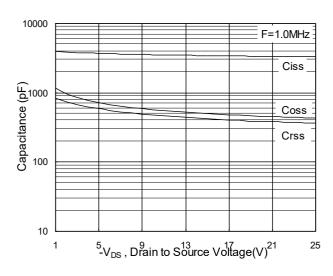


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>



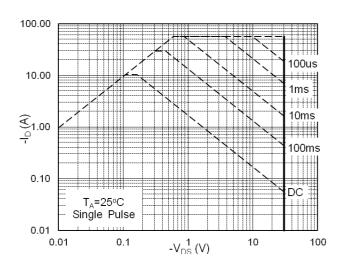


Fig.7 Capacitance

Fig.8 Safe Operating Area

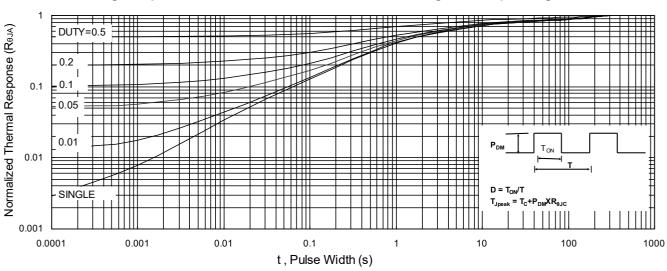


Fig.9 Normalized Maximum Transient Thermal Impedance

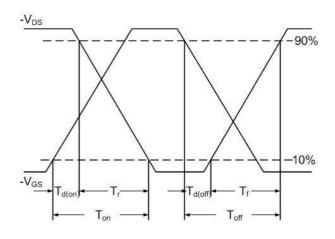


Fig.10 Switching Time Waveform

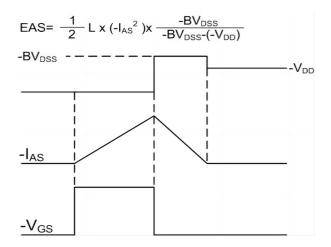
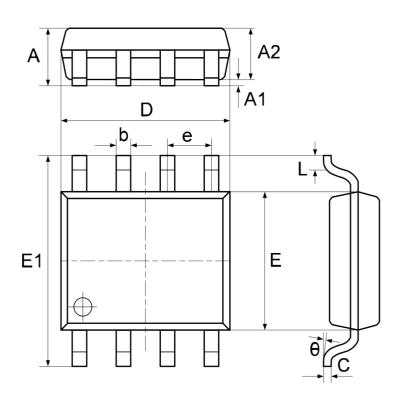


Fig.11 Unclamped Inductive Switching Waveform



# **Package Information**

#### SOP-8



Symbol	Dimensions In Millimeters		Dimensions In Inches		
_	Min	Max	Min	Max	
Α	1.370	1.670	0.056	0.068	
A1	0.070	0.170	0.003	0.007	
A2	1.300	1.500	0.053	0.061	
b	0.306	0.506	0.013	0.021	
С	0.203 typ.		0.008 typ.		
D	4.700	5.100	0.192	0.208	
Е	3.820	4.020	0.156	0.164	
E1	5.800	6.200	0.237	0.253	
е	1.270 typ.		0.050 typ.		
L	0.450	0.750	0.018	0.306	
θ	0°	8°	0°	8°	



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